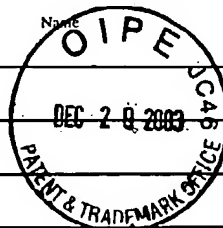


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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Janine K. Kardokus et al.		GROUP 1742	
				FILING DATE December 19, 2001			
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						Yes	No
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A	AR	Yeon et al., "Electrical Characteristics of the MOD-derived SrBi2xTa2O9 and SrBi2.4(TA,Nb)2O9 Thin Films", Journal of Materials Science, 35(10), pgs. 2405-2411, May 15, 2000. Abstract only.					
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EXAMINER S. Kastler				DATE CONSIDERED 2-04			
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